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# RESISTORS, FIXED, SURFACE MOUNT, FILM, NON-HERMETICALLY SEALED BASED ON TYPE MS1

ESCC Detail Specification No. 4001/022

## ISSUE 2 December 2006





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## **DOCUMENTATION CHANGE NOTICE**

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DCR No.	CHANGE DESCRIPTION
293	Specification upissued to incorporate technical and editorial changes per DCR.
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APPENDICES (Applicable to specific Manufacturers only) None.



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#### 1. **GENERAL**

#### 1.1 SCOPE

This specification details the ratings, physical and electrical characteristics, test and inspection data for Resistors, Fixed, Surface Mount, Film, Non-hermetically Sealed, based on Type MS1. It shall be read in conjunction with ESCC Generic Specification No. 4001, the requirements of which are supplemented herein.

#### 1.2 RANGE OF COMPONENTS

The range of resistors covered by this specification are given in Table 1(a).

#### 1.3 MAXIMUM RATINGS

The maximum ratings, which shall not be exceeded at any time during use or storage, applicable to the resistors specified herein, are as scheduled in Table 1(b).

#### 1.4 PARAMETER DERATING INFORMATION

The parameter derating information applicable to the resistors specified herein is given in Figure 1.

#### 1.5 PHYSICAL DIMENSIONS

The physical dimensions of the resistors specified herein, are shown in Figure 2.

#### 1.6 FUNCTIONAL DIAGRAM

The functional diagram for the resistors specified herein, is shown in Figure 3.

#### 2. APPLICABLE DOCUMENTS

The following documents form part of this specification and shall be read in conjunction with it:-

(a) ESCC Generic Specification No. 4001, Resistors, Fixed, Film.

#### 3. TERMS, DEFINITIONS, ABBREVIATIONS, SYMBOLS AND UNITS

For the purpose of this specification, the terms, definitions, abbreviations, symbols and units specified in ESCC Basic Specification No. 21300 shall apply. In addition, the following symbols are used:-

 $V_T$  = Test Voltage.

TC = Temperature Coefficient.



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## **TABLE 1(a) - RANGE OF COMPONENTS**

Resistance Range (Note 1)		Tolerance	Value	Temperature Coefficient
MIN. (Ω)	MAX. (MΩ)	(±%)	Series	(±10−6/°C)
43.2	1.0	0.1	E96	50
10.0	1.0	0.5	E96	50
2.21	5.11	1.0	E96	50
43.2	1.0	0.1	E96	25
10.0	1.0	0.5	E96	25
10.0	1.0	1.0	E96	25
43.2	0.221	0.1	E96	15
10.0	0.511	0.5	E96	15

#### **NOTES**

1. Critical resistance = 160 000 $\Omega$ 

#### **TABLE 1(b) - MAXIMUM RATINGS**

No.	Characteristics	Symbol	Limits	Unit	Remarks
1	Rated Dissipation	Pn	0.25	W	Note 1
2	Limiting Element Voltage	UL	200	٧	-
3	Rated Voltage	U <sub>R</sub>	$\sqrt{(0.25 R_n)}$	٧	Note 2
4	Insulation Voltage	Ui	>500	Vrms	-
5	Operating Temperature Range	T <sub>op</sub>	−55 to +125	°C	T <sub>amb</sub>
6	Storage Temperature Range	T <sub>stg</sub>	-65 to +155	°C	-
7	Soldering Temperature	T <sub>sol</sub>	+ 260	°C	Note 3

#### NOTES

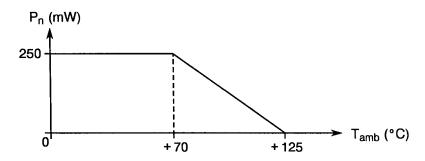
- $\overline{\text{1. At T}_{\text{amb}}} \le$  +70 °C. For derating at  $\text{T}_{\text{amb}} >$  +70 °C, see Figure 1.
- 2. Shall never exceed Limiting Element Voltage.
- 3. Duration 10 seconds maximum.



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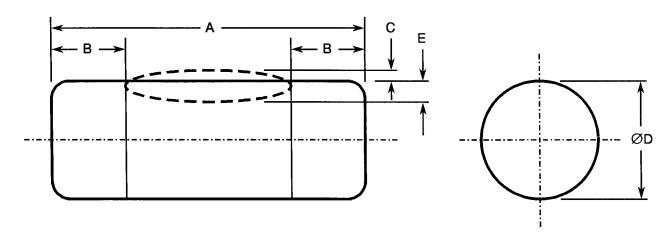
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## FIGURE 1 - PARAMETER DERATING INFORMATION



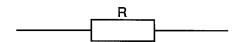
Rated Dissipation versus Temperature

## **FIGURE 2 - PHYSICAL DIMENSIONS**



Symbol	Millimetres		Notes
Symbol	Min.	Max.	Notes
Α	3.4	3.6	
В	0.5	0.9	
С	-	0.05	
ØD	1.3	1.5	
E	-	0.1	

**FIGURE 3 - FUNCTIONAL DIAGRAM** 





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#### 4. REQUIREMENTS

#### 4.1 GENERAL

The complete requirements for procurement of the resistors specified herein shall be as stated in this specification and ESCC Generic Specification No. 4001. Deviations from the Generic Specification, applicable to this specification only, are listed in Para. 4.2.

Deviations from the applicable Generic Specification and this Detail Specification, formally agreed with specific Manufacturers on the basis that the alternative requirements are equivalent to the ESCC requirements and do not affect the components' reliability, are listed in the appendices attached to this specification.

#### 4.2 <u>DEVIATIONS FROM GENERIC SPECIFICATION</u>

#### 4.2.1 <u>Deviations from Special In-process Controls</u>

None.

#### 4.2.2 <u>Deviations from Final Production Tests (Chart II)</u>

(a) Para. 9.1, Overload: The test conditions shall be as follows:-

Voltage:  $\sqrt{2.5 R_n}$  or 630V, whichever is less.

Duration:  $(0.1 \pm 0.01)$ s

 $\Delta^{R}/_{R}$  :  $\leq \pm (0.25\% R_{n} + 0.05\Omega)$ 

#### 4.2.3 Deviations from Burn-in and Electrical Measurements (Chart III)

- (a) No serialisation of parts.
- (b) Para. 9.5.2, Parameter Drift Value Measurements: not applicable.
- (c) Para. 7.1.1, Conditions for Burn-in Test, and Para. 9.18, Burn-in: not applicable.
- (d) Para. 9.3, Seal Test: not applicable.
- (e) Para. 9.17, External Visual Inspection: In addition to the applicable ESCC Basic Specification, the following specific requirements must be considered:
  - There shall be no gap at the lacquer-cap junction. However, after temperature testing hairline cracks shall be allowed between the lacquer and the cap.
  - The termination (cap) must be free of any lacquer for the dimension "B min" given in Figure 2.
  - Pretinning shall exhibit a clean smooth surface, without pin holes or rough spots concentrated in one place, and without irregular solder balling.

#### 4.2.4 <u>Deviations from Qualification Tests (Chart IV)</u>

- (a) Para. 9.1, Overload: Test conditions as Para. 4.2.2(a).
- (b) Para. 9.10.2.3, Bend Strength of the End Face Plating: Not applicable.
- (c) Para. 9.12, Rapid Change of Temperature: Not applicable.
- (d) Para. 9.13, Vibration: Not applicable.

#### 4.2.5 <u>Deviations from Lot Acceptance Tests (Chart V)</u>

- (a) Para. 9.10.2.3, Bend Strength of the End Face Plating: Not applicable.
- (b) Para. 9.13, Vibration: Not applicable.



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#### 4.3 MECHANICAL REQUIREMENTS

#### 4.3.1 Dimension Check

The dimensions of the resistors specified herein shall be verified in accordance with the requirements set out in Para. 9.4 of ESCC Generic Specification No. 4001 and shall conform to those shown in Figure 2 of this specification.

#### 4.3.2 Weight

The maximum weight of the resistors specified herein shall be 0.1 grammes.

#### 4.3.3 Robustness of Terminations

The requirements and test conditions for robustness of terminations are specified in Section 9 of ESCC Generic Specification No. 4001.

#### 4.4 MATERIALS AND FINISHES

The materials and finishes shall be as specified herein. Where a definite material is not specified, a material which will enable the components specified herein to meet the performance requirements of this specification shall be used. Acceptance or approval of any constituent material does not guarantee acceptance of the finished product.

#### 4.4.1 Case

As a minimum, the resistance element shall be protected by a suitable laquer coating.

#### 4.4.2 Terminations

The end-cap material shall be steel with 1.0 µm nickel plating and with a tin-lead plated finish (minimum 6% lead).

#### 4.4.3 Films

Films shall be uniformly deposited. They shall be free from blisters, thin spots, areas inadequately bonded to the core, discoloured spots or other blemishes likely to cause flaking or non-uniform ribbons when spiralled (helixed). When used, spiralling shall occupy at least 70% of the active length of the resistance element.

#### 4.5 MARKING

#### 4.5.1 General

The marking of all components delivered to this specification shall be in accordance with the requirements of ESCC Basic Specification No. 21700 and the following paragraphs. When the component is too small to accommodate all of the marking specified, as much as space permits shall be marked and the marking information, in full, shall accompany each component in its primary package.

The infomation to be marked and the order of precedence, shall be as follows:-

- (a) The ESCC Component Number.
- (b) The Electrical Characteristics and Ratings.
- (c) Traceability Information.



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Each component shall bear the ESCC Component Number as follows:	r which shall be constituted and marked 400102201B
Detail Specification Number —	
Type Variant (see Note)	
Testing Level (B or C, as applicable)	

#### N.B.

Marking of the Type Variant Number is mandatory. No further reference to type variants is made in this specification.

#### 4.5.3 Electrical Characteristics and Ratings

The electrical characteristics and ratings to be marked in the following order of precedence are:-

- (a) Resistance Value.
- (b) Tolerance.
- (c) Temperature Coefficient.

The information shall be constituted and r	marked as follows:	2490 <u>F3</u>
Value (249 Ohms)		<b>-</b>
Tolerance (±1.0%)		
Temperature Coefficient (±50 10-6/°C)		

#### 4.5.3.1 Resistance Values

Resistance values shall be expressed by means of the following codes. The unit quantity for marking shall be ohms  $(\Omega)$ .

Resistance Value	Code
XX.X	XXRX
XXX	XXX0
XXX10 <sup>1</sup>	XXX1
XXX10 <sup>2</sup>	XXX2
XXX10 <sup>3</sup>	XXX3
XXX10 <sup>4</sup>	XXX4

For values of  $100\Omega$  and above, the first 3 digits (X) represent significant figures and the last digit specifies the number of zeros to follow.

When values of less than  $100\Omega$  are required, the letter 'R' is used to indicate the decimal point. When the letter is used, all successive digits represent significant figures.

#### 4.5.3.2 Tolerance

The tolerance on resistance values shall be indicated by the code letters specified hereafter.

Tolerance (±%)	Code Letter
0.1	В
0.5	D
1.0	F



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#### 4.5.3.3 Temperature Coefficient

The temperature coefficient shall be indicated by the numerical codes specified hereafter.

Digit	Temperature Coefficient (±10-6/°C)
1	15
2	25
3	50

#### 4.5.3.4 Marking of the Resistors

A colour code shall be applied in accordance with ESCC Basic Specification No. 21700.

Marking of the temperature coefficient shall be either with a colour dot or with a body colour as specified hereafter.

TC (±10 <sup>-6</sup> /°C)	Colour Dot	Body Colour		
15 25	Orange Yellow	Violet Pink		
50 50	None	Beige		

#### 4.5.4 Traceability Information

Each component shall be marked in respect of traceability information in accordance with the requirements of ESCC Basic Specification No. 21700.

#### 4.6 ELECTRICAL MEASUREMENTS

## 4.6.1 <u>Electrical Measurements at Room Temperature</u>

The parameters to be measured at room temperature are scheduled in Table 2. Unless otherwise specified, the measurements shall be performed at  $T_{amb}$  = +22 ±3 °C.

#### 4.6.2 <u>Electrical Measurements at High and Low Temperatures</u>

The parameters to be measured on a sample basis at high and low temperatures are scheduled in Table 3.

The distribution of the sample shall be as follows:

- 1/3 with the lowest resistance value.
- 1/3 with the highest resistance value.
- 1/3 with the median resistance value or the critical resistance value if procured, of the procured range.

#### 4.6.3 Circuits for Electrical Measurements (Figure 4)

Not applicable.



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#### TABLE 2 - ELECTRICAL MEASUREMENTS AT ROOM TEMPERATURE

No. C	Characteristics	naractoristics   Symbol	Symbol ESCC 4001 Test Conditions Tolerence (±%)	Tolerence	Limits		Unit	
				Conditions	(±%)	Min.	Мах.	
1	Resistance	R <sub>A</sub>	Para. 9.5.1	Para. 9.5.1	0.1 0.5 1.0	0.999 Rn 0.995 Rn 0.990 Rn	1.001 Rn 1.005 Rn 1.010 Rn	Ω

#### TABLE 3 - ELECTRICAL MEASUREMENTS AT HIGH AND LOW TEMPERATURES

No.	Chavastavistica	O. mala al	ESCC 4001	Test Conditions	Limits		Unit
	Characteristics	Symbol	Test Method	(Note 1)	Min.	Max.	Offic
2	Resistance Change between -55(+3-0) °C and +22±3 °C	<u>ΔR</u> R	Para. 9.5.1	Para. 9.5.1 ± 15 10-6/°C ± 25 10-6/°C ± 50 10-6/°C	-0.12 -0.2 -0.4	+ 0.12 + 0.2 + 0.4	%
3	Resistance Change between +125(+0-3) °C and +22±3 °C	<u>∆R</u> R	Para. 9.5.1	Para. 9.5.1 ± 15 10-6/°C ± 25 10-6/°C ± 50 10-6/°C	-0.16 -0.26 -0.55	+ 0.16 + 0.26 + 0.55	%

#### **NOTES**

#### FIGURE 4 - CIRCUITS FOR ELECTRICAL MEASUREMENTS

Not applicable.

#### **TABLE 4 - PARAMETER DRIFT VALUES**

Not applicable.

<sup>1.</sup> The measurements shall be performed on a sample basis in accordance with General Inspection Level II, Table IIA, AQL = 0.65% of IEC Publication No. 410 on the total production lot. In addition, see Para. 4.6.2 for distribution of the sample.



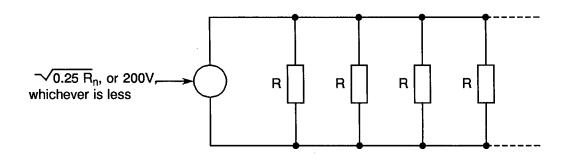
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## TABLE 5 - CONDITIONS FOR OPERATING LIFE TEST

No.	Characteristics	Symbol	Condition	Unit
1	Ambient Temperature	T <sub>amb</sub>	+70(+0-3)	°C
2	Test Voltage	V <sub>T</sub>	√0.25 R <sub>n</sub> , or 200V, whichever is less	V

## FIGURE 5 - ELECTRICAL CIRCUIT FOR OPERATING LIFE TEST





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## 4.7 <u>ENVIRONMENTAL AND ENDURANCE TESTS (CHARTS IV AND V OF ESCC GENERIC SPECIFICATION No. 4001)</u>

The resistors shall be mounted as prescribed in ESCC Generic Specification No. 4001, Para. 9.20. The substrate material shall be epoxy glass laminated board.

#### 4.7.1 Measurements and Inspections on Completion of Environmental Tests

The parameters to be measured and inspections to be performed on completion of environmental tests are scheduled in Table 6. Unless otherwise stated, the measurements shall be performed at  $T_{amb}$  = +22 ±3 °C.

#### 4.7.2 Measurements and Inspections at Intermediate Points during Endurance Tests

The parameters to be measured and inspections to be performed at intermediate points during endurance tests are scheduled in Table 6 of this specification. Unless otherwise stated, the measurements shall be performed at  $T_{amh} = +22 \pm 3$  °C.

#### 4.7.3 Measurements and Inspections on Completion of Endurance Tests

The parameters to be measured and inspections to be performed on completion of endurance testing are scheduled in Table 6 of this specification. Unless otherwise stated, the measurements shall be performed at  $T_{amb}$  = +22 ±3 °C.

#### 4.7.4 Conditions for Operating Life Tests (Part of Endurance Testing)

The requirements for operating life testing are specified in Section 9 of ESCC Generic Specification No. 4001. The conditions for operating life testing shall be as specified in Table 5 of this specification.

#### 4.7.5 Electrical Circuits for Operating Life Tests

Circuits for use in performing the operating life tests are shown in Figure 5 of this specification.

#### 4.7.6 Conditions for High Temperature Storage Test (Part of Endurance Testing)

The requirements for the high temperature storage test are specified in ESCC Generic Specification No. 4001. The conditions for high temperature storage shall be  $T_{amb} = +125(+0-5)$  °C.



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## TABLE 6 - MEASUREMENTS AND INSPECTIONS ON COMPLETION OF ENVIRONMENTAL TESTS AND AT INTERMEDIATE POINTS AND ON COMPLETION OF ENDURANCE TESTING

	ESCC GENERIC SF	PEC. No. 4001	MEASUREMENTS AND INSPECTIONS			LIMITS		
No.	ENVIRONMENTAL AND ENDURANCE TESTS (1)	TEST METHOD AND CONDITIONS	IDENTIFICATION	CONDITIONS	SYMBOL	MIN.	MAX.	UNIT
01	Overload	Para. 9.1 and Paras. 4.2.2 and 4.2.4 of this spec.	Initial Measurements Chart IV Resistance Final Measurements Visual Examination Chart II Resistance Chart IV Resistance Change	Table 2 Item 1 After a recovery period of 1-2 hours No evidence of damage and marking legible Table 2 Item 1 Table 2 Item 1	R <sub>A</sub> - R <sub>A</sub> ΔR <sub>A</sub> /R <sub>A</sub>		- 2 Item 1 0.05Ωx100)	- %
02	Seal Test (Hermetically Sealed only)	Para. 9.3	Not applicable				Rn	
	Insualtion Resistance (Insulated only)  Temperature Coefficient	Para. 9.6 Para. 9.7	Final Measurements Insulation Resistance Temperature Coefficient	Para. 9.6.2 of ESCC 4001 (2) Para. 9.5.1 of ESCC	Ri	1000 -15	- +15	MΩ 10 <sup>-6</sup> /
	·	Procedure I		4001		- 25 - 50	+ 25 + 50	°C
05	Voltage Proof	Para. 9.8	During Test Visual Examination	1.4xU <sub>i</sub> (3) for 60 ± 5 sec No breakdown or flashover	-	-	-	-
06	Solderability	Para. 9.9 Procedure I	Initial Measurements Resistance Final Measurements Resistance Change	After Drying Table 2 Item 1 24 ± 4 hrs after soldering Table 2 Item 1	$R_A$ $\Delta R_A/R_A$	Record ± (0.15+)	Values 0.05Ωx100)	%
07	Robustness of Terminations	Para. 9.10.2 Adhesion  Paras. 4.2.4 and 4.2.5 of this spec. Bend Strength of	Initial Measurements Resistance Final Measurements Resistance Change Visual Examination Not applicable	After mounting Table 2 Item 1 Table 2 Item 1 No damage, lifting, cracking or dry joints	- R <sub>A</sub> ΔR <sub>A</sub> /R <sub>A</sub>		Rn - I Values 0.05Ωx100) Rn -	- % -
08	Resistance to Soldering Heat	End Plate Facing Para. 9.11 Procedure I	Initial Measurements Resistance Final Measurements Visual Examination Resistance Change	After drying Table 2 Item 1  No evidence of damage and marking legible After 24 ± 4 hours Table 2 Item 1	R <sub>A</sub> - ΔR <sub>A</sub> /R <sub>A</sub>	-	d Values - 0.05Ωx100) Rn	- %
09	Rapid Change of Temperature	Para. 9.12 and Para. 4.2.4 of this spec.	Not applicable					
10	Vibration	Para. 9.13 and Paras. 4.2.4 and 4.2.5 of this spec.	Not applicable					

## **NOTES**

- 1. The tests in this Table refer to either Chart IV or V and shall be use as applicable.
- Test Voltage: V<sub>T</sub> = 100V.
   For value of U<sub>i</sub>, see Table 1(b) Item 4.



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# TABLE 6 - MEASUREMENTS AND INSPECTIONS ON COMPLETION OF ENVIRONMENTAL TESTS AND AT INTERMEDIATE POINTS AND ON COMPLETION OF ENDURANCE TESTING (CONT'D)

	ESCC GENERIC SP	ESCC GENERIC SPEC. No. 4001 MEASUREMENTS AND INSPECTIONS		PEC. No. 4001 MEASUREMENTS AND INSPECTION		ND INSPECTIONS		LIMITS		
No.	ENVIRONMENTAL AND ENDURANCE TESTS (1)	TEST METHOD AND CONDITIONS	IDENTIFICATION	CONDITIONS	SYMBOL	MIN.	MAX.	UNIT		
11	Climatic Sequence	Para. 9.14 Procedure I	Initial Measurements Resistance Final Measurements	After Drying Table 2 Item 1 Following completion of D.C. load test and after a recovery		Record	Values			
			Visual Examination	period of 1-2 hrs No evidence of damage and marking legible	-	-	-	-		
			Insulation Resistance	Para. 9.6 of ESCC 4001 (2)	Ri	1000	-	мΩ		
		i	Resistance Change	Table 2 Item 1	$\Delta R_A/R_A$	± (0.5 + <u>0</u>	. <u>05Ωx100</u> ) Rn	%		
12	Operating Life	Para. 9.15 Chart IV	Initial Measurements Resistance Intermediate Measurements (1000 hrs)	Table 2 Item 1 After a recovery period of 1-2 hrs	R <sub>A</sub>	Record	Values			
			Visual Examination	No evidence of damage	- 4D /D	+ (0.35+)	- 0.05Ωx100)	- 0/		
			Resistance Change	Table 2 Item 1	$\Delta R_A/R_A$	± (0.55 + <u>1</u>	Rn	%		
			Final Measurements (2000 hrs) Visual Examination	After a recovery period of 1-2 hrs No evidence of damage	-	-	-	-		
			Resistance Change	Table 2 Item 1	$\Delta R_A/R_A$	± (0.5 + <u>0</u>	.05Ωx100) Rn	%		
			Insulation Resistance	Para. 9.6 of ESCC 4001 (2)	Ri	1000	-	мΩ		
		Para. 9.15 Chart V	Initial Measurements Resistance Final Measurements (1000 hrs)	Table 2 Item 1 After a recovery period of 1-2 hrs	R <sub>A</sub>	Record	Values			
			Visual Examination Resistance Change	No evidence of damage Table 2 Item 1	ΔR <sub>A</sub> /R <sub>A</sub>	+ (0.35 +	- 0.05Ωx100)	- %		
			Insulation Resistance	Para. 9.6 of	Ri	1000	Rn	мΩ		
13	High Temperature Storage	Para 0.16	Initial Measurements	ESCC 4001 (2)		1000				
	Trigit Tomporatoro Otorage	1 444. 5.10	Resistance Intermediate Measurements (1000 hrs)	Table 2 Item 1 After a recovery period of 1-2 hrs	R <sub>A</sub>	Record	d Values			
			Visual Examination	No evidence of damage	-	-	-	-		
1			Resistance Change	Table 2 Item 1	$\Delta R_A/R_A$	± (0.35+	0.05Ωx100) Rn	%		
			Final Measurements (2000 hrs) Visual Examination	After recovery period of 1-2 hrs No evidence of	-	_	-	-		
			Resistance Change	damage Table 2 Item 1	ΔR <sub>A</sub> /R <sub>A</sub>	± (0.5 + <u>0</u>	1 0.05Ωx100)	%		
			Insulation Resistance	Para. 9.6 of ESCC 4001 (2)	Ri	1000	Rn -	мΩ		
14	Permanence of Marking	Para. 9.19	Final Measurements Visual Examination	No corrosion or abliteration of marking						

**NOTES:** See Page 15.